



High-end Power Semiconductor Manufacturer

# KK1600A 3800-4000V Fast Switching Thyristor

- Low switching losses
- Low reverse recovery charge
- Distributed amplified gate for high  $dI_T/dt$



Mean on-state current	$I_{TAV}$	1600 A
Repetitive peak off-state voltage	$V_{DRM}$	3800 – 4000 V
Repetitive peak reverse voltage	$V_{RRM}$	
Turn-off time	$t_q$	125; 160 $\mu s$
$V_{DRM}, V_{RRM}, V$	3800	4000
Voltage code	38	40
$T_i, ^\circ C$	– 60 – 125	

## MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions	
<b>ON-STATE</b>					
$I_{TAV}$	Mean on-state current	A	1600 2400	$T_c=85^\circ C$ ; Double side cooled; $T_c=55^\circ C$ ; 180° half-sine wave; 50 Hz	
$I_{TRMS}$	RMS on-state current	A	2510	$T_c=85^\circ C$ ; Double side cooled; 180° half-sine wave; 50 Hz	
$I_{TSM}$	Surge on-state current	kA	32.0 37.0	$T_j=T_{j \max}$ $T_j=25^\circ C$	180° half-sine wave; 50 Hz ( $t_p=10$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=I_{FGM}$ ; $V_G=20$ V; $t_{GP}=50$ $\mu s$ ; $di_G/dt=2$ A/ $\mu s$
			34.0 39.0	$T_j=T_{j \max}$ $T_j=25^\circ C$	180° half-sine wave; 60 Hz ( $t_p=8.3$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=I_{FGM}$ ; $V_G=20$ V; $t_{GP}=50$ $\mu s$ ; $di_G/dt=2$ A/ $\mu s$
$I^2t$	Safety factor	$A^2s \cdot 10^3$	5120 6845	$T_j=T_{j \max}$ $T_j=25^\circ C$	180° half-sine wave; 50 Hz ( $t_p=10$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=I_{FGM}$ ; $V_G=20$ V; $t_{GP}=50$ $\mu s$ ; $di_G/dt=2$ A/ $\mu s$
			4795 6310	$T_j=T_{j \max}$ $T_j=25^\circ C$	180° half-sine wave; 60 Hz ( $t_p=8.3$ ms); single pulse; $V_D=V_R=0$ V; Gate pulse: $I_G=I_{FGM}$ ; $V_G=20$ V; $t_{GP}=50$ $\mu s$ ; $di_G/dt=2$ A/ $\mu s$
<b>BLOCKING</b>					
$V_{DRM}, V_{RRM}$	Repetitive peak off-state and Repetitive peak reverse voltages	V	3800–4000	$T_{j \min} < T_j < T_{j \max}$ 180° half-sine wave; 50 Hz; Gate open	
$V_{DSM}, V_{RSM}$	Non-repetitive peak off-state and Non-repetitive peak reverse voltages	V	3900–4100	$T_{j \min} < T_j < T_{j \max}$ 180° half-sine wave; 50 Hz; single pulse; Gate open	
$V_D, V_R$	Direct off-state and Direct reverse voltages	V	$0.75 \cdot V_{DRM}$ $0.75 \cdot V_{RRM}$	$T_j=T_{j \max}$ Gate open	

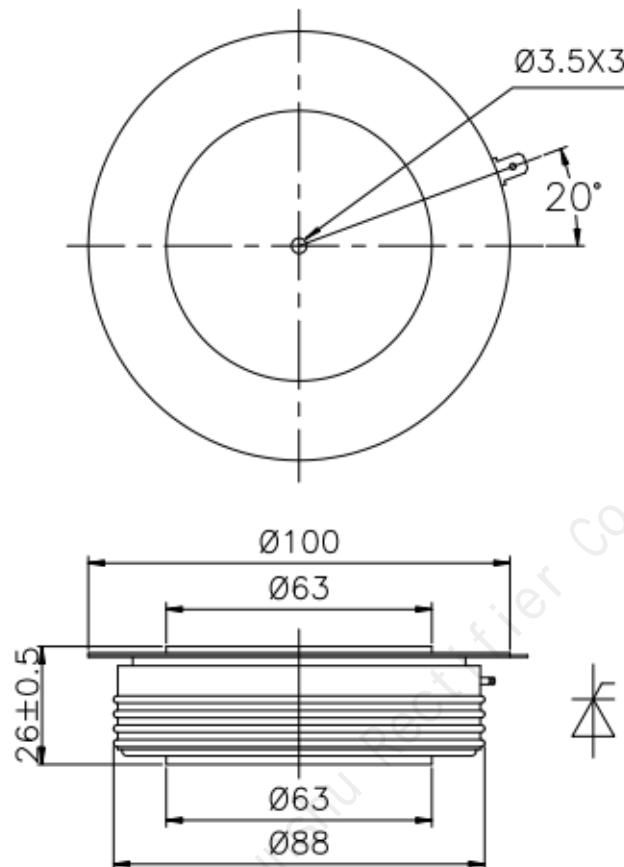
TRIGGERING				
$I_{FGM}$	Peak forward gate current	A	10	$T_j = T_{j \max}$
$V_{RGM}$	Peak reverse gate voltage	V	5	
$P_G$	Gate power dissipation	W	8	
SWITCHING				
$(di_T/dt)_{crit}$	Critical rate of rise of on-state current non-repetitive ( $f=1$ Hz)	$A/\mu s$	2000	$T_j = T_{j \max}; V_D = 0.67 V_{DRM}; I_{TM} = 2 I_{TAV};$ Gate pulse: $I_G = I_{FGM}$ ; $V_G = 20$ V; $t_{GP} = 50 \mu s$ ; $di_G/dt = 2 A/\mu s$
THERMAL				
$T_{stg}$	Storage temperature	$^{\circ}C$	-60 – 125	
$T_j$	Operating junction temperature	$^{\circ}C$	-60 – 125	
MECHANICAL				
F	Mounting force	kN	40.0 – 50.0	
a	Acceleration	$m/s^2$	50 100	Device unclamped Device clamped

## CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions		
ON-STATE						
$V_{TM}$	Peak on-state voltage, max	V	2.70	$T_j = 25$ °C; $I_{TM} = 5024$ A		
$V_{T(TO)}$	On-state threshold voltage, max	V	1.44	$T_j = T_{j \max};$ $0.5 \pi I_{TAV} < I_T < 1.5 \pi I_{TAV}$		
$r_T$	On-state slope resistance, max	$m\Omega$	0.270			
$I_H$	Holding current, max	mA	1000	$T_j = 25$ °C; $V_D = 12$ V; Gate open		
BLOCKING						
$I_{DRM}, I_{RRM}$	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	300	$T_j = T_{j \max};$ $V_D = V_{DRM}; V_R = V_{RRM}$		
$(dv_D/dt)_{crit}$	Critical rate of rise of off-state voltage <sup>1)</sup> , min	$V/\mu s$	1000	$T_j = T_{j \max};$ $V_D = 0.67 \cdot V_{DRM}$ ; Gate open		
TRIGGERING						
$V_{GT}$	Gate trigger direct voltage, max	V	5.00 3.00 2.00	$T_j = T_{j \min}$ $T_j = 25$ °C $T_j = T_{j \max}$	$V_D = 12$ V; $I_D = 3$ A; Direct gate current	
$I_{GT}$	Gate trigger direct current, max	mA	500 300 200	$T_j = T_{j \min}$ $T_j = 25$ °C $T_j = T_{j \max}$		
$V_{GD}$	Gate non-trigger direct voltage, min	V	0.35	$T_j = T_{j \max}; V_D = 0.67 V_{DRM};$ Direct gate current		
$I_{GD}$	Gate non-trigger direct current, min	mA	15.00			
SWITCHING						
$t_{gd}$	Delay time	$\mu s$	3.5	$T_j = 25$ °C; $V_D = 0.4 V_{DRM}; I_{TM} = I_{TAV};$ Gate pulse: $I_G = I_{FGM}$ ; $V_G = 20$ V; $t_{GP} = 50 \mu s$ ; $di_G/dt = 2 A/\mu s$		
$t_q$	Turn-off time <sup>2)</sup> , max	$\mu s$	125; 160	$dv_D/dt = 50 V/\mu s;$	$T_j = T_{j \max};$ $I_{TM} = I_{TAV};$	
			160; 200	$dv_D/dt = 200 V/\mu s;$	$di_R/dt = -10 A/\mu s;$ $V_R = 100V;$ $V_D = 0.67 V_{DRM}$	
$Q_{rr}$	Total recovered charge(linear), max	$\mu C$	3000	$T_j = T_{j \max}; I_{TM} = 2000$ A; $di_R/dt = -50 A/\mu s;$ $V_R = 100$ V		
$t_{rr}$	Reverse recovery time, max	$\mu s$	14			
$I_{rrM}$	Peak reverse recovery current, max	A	430			

<b>THERMAL</b>					
$R_{thjc}$	Thermal resistance, junction to case, max	$^{\circ}\text{C}/\text{W}$	0.0085	Direct current	Double side cooled
$R_{thjc-A}$			0.0187		Anode side cooled
$R_{thjc-K}$			0.0153		Cathode side cooled
$R_{thck}$	Thermal resistance, case to heatsink, max	$^{\circ}\text{C}/\text{W}$	0.0020	Direct current	
<b>MECHANICAL</b>					
w	Weight, typ	g	1500		
$D_s$	Surface creepage distance	mm (inch)	36.6 (1.441)		
$D_a$	Air strike distance	mm (inch)	16.2 (0.638)		

## OVERALL DIMENSIONS



KT70

All dimensions in millimeters

### On-state characteristic model (see Fig. 1).

Analytical function for On-state characteristic:

$$V_T = A + B \cdot i_T + C \cdot \ln(i_T + 1) + D \cdot \sqrt{i_T}$$

	Coefficients	
	$T_j = 25^\circ\text{C}$	$T_j = T_{j\max}$
<b>A</b>	1.799223	1.165741
<b>B</b>	0.106392	0.195115
<b>C</b>	-0.227901	-0.304378
<b>D</b>	0.350140	0.467637

### Transient thermal impedance junction to case $Z_{thjc}$ model (see Fig. 2).

Analytical function for Transient thermal impedance junction to case  $Z_{thjc}$  for DC:

$$Z_{thjc} = \sum_{i=1}^n R_i \left( 1 - e^{-\frac{t}{\tau_i}} \right)$$

Where  $i = 1$  to  $n$ ,  $n$  is the number of terms in the series.

$t$  = Duration of heating pulse in seconds.

$Z_{thjc}$  = Thermal resistance at time  $t$ .

$R_i$  = Amplitude of  $p_{th}$  term.

$\tau_i$  = Time constant of  $r_{th}$  term.

DC Double side cooled

i	1	2	3	4	5	6
$R_i, \text{K/W}$	0.00007989	0.002973	0.0005936	0.000846	0.00005975	0.003948
$\tau_i, \text{s}$	1.688	0.06219	0.002329	0.138	0.0003243	0.9533

DC Anode side cooled

i	1	2	3	4	5	6
$R_i, \text{K/W}$	0.01013	0.004062	0.0009401	0.002853	0.0005963	0.00005641
$\tau_i, \text{s}$	9.747	1.058	0.1304	0.06179	0.002313	0.0003013

DC Cathode side cooled

i	1	2	3	4	5	6
$R_i, \text{K/W}$	0.006619	0.004034	0.0008595	0.002956	0.0005965	0.00005689
$\tau_i, \text{s}$	9.744	1.025	0.1394	0.06237	0.002318	0.0003037

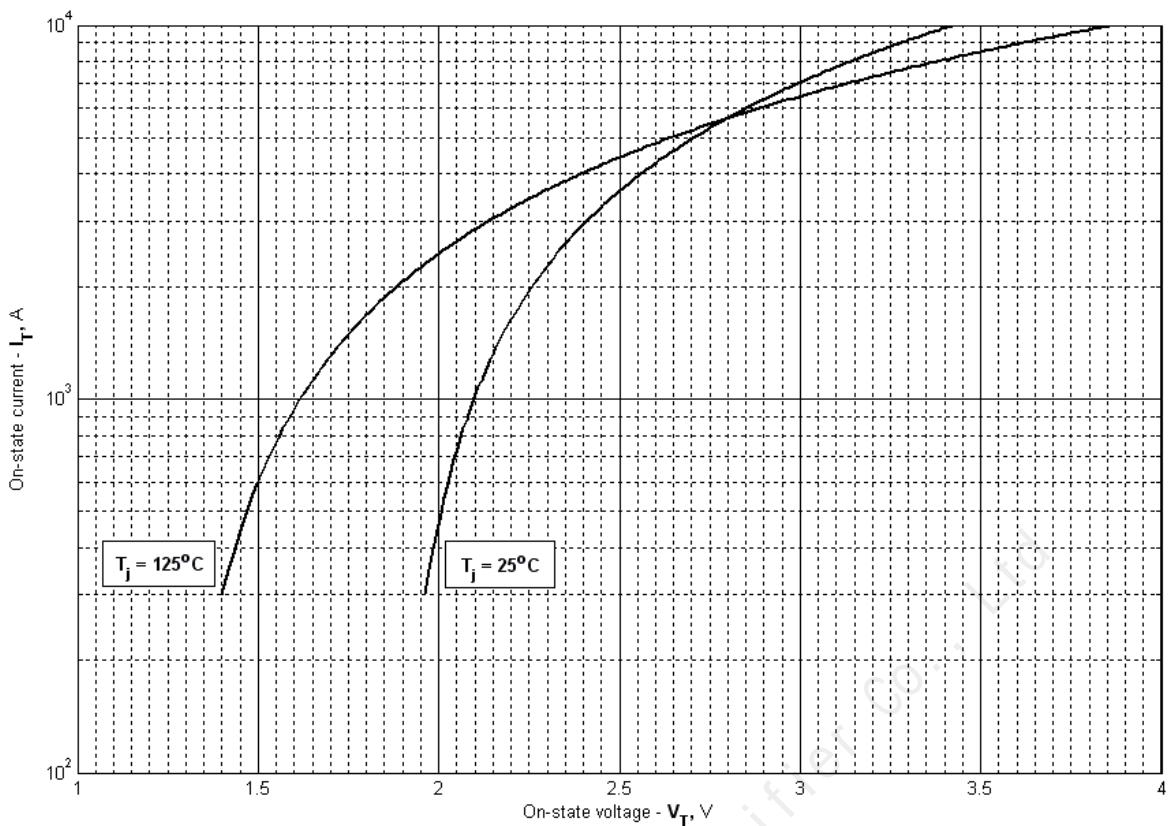


Fig 1 – On-state characteristics of Limit device

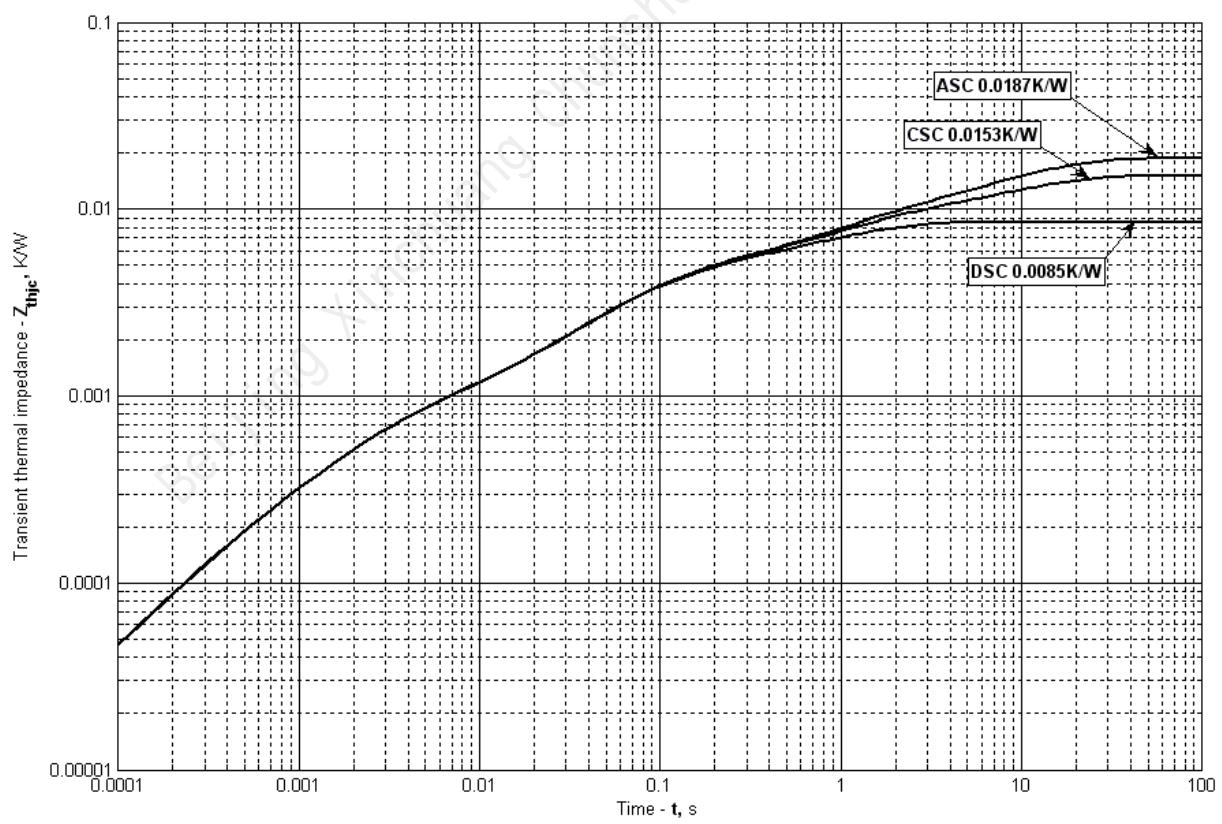


Fig 2 – Transient thermal impedance

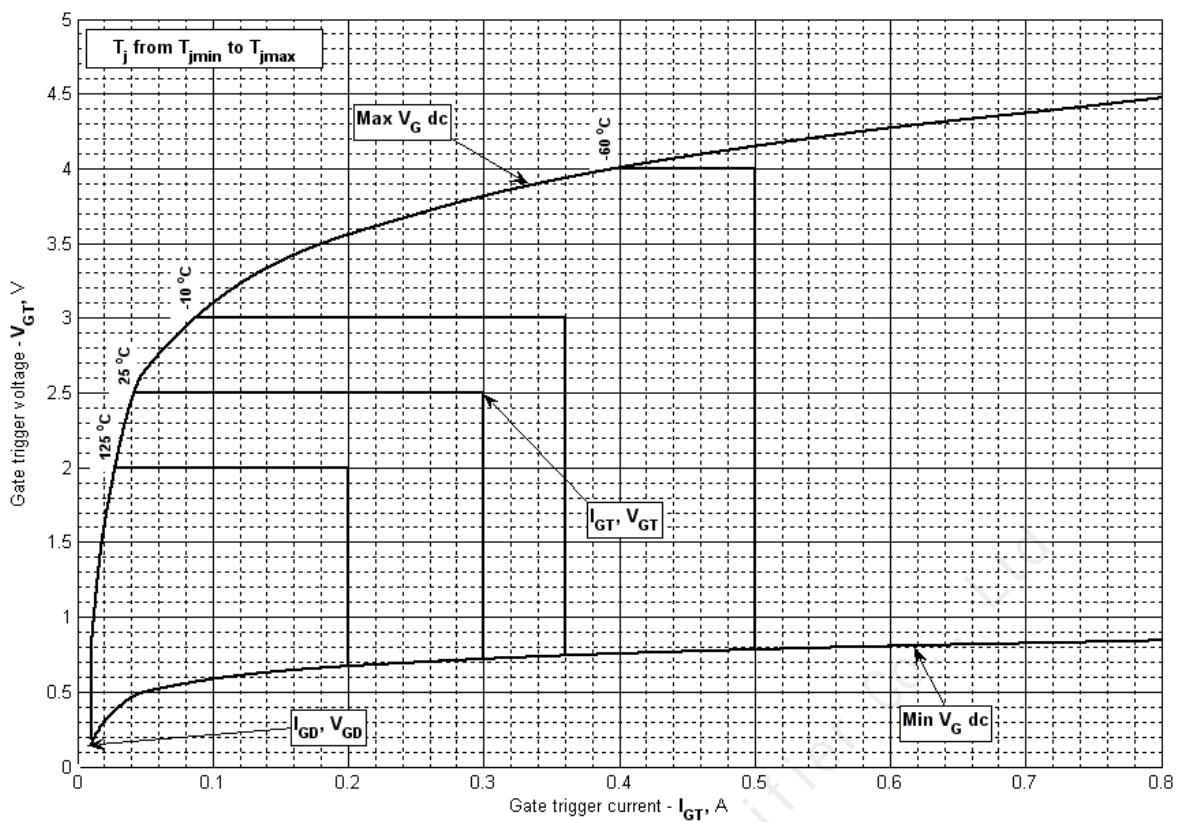


Fig 3 – Gate characteristics – Trigger limits

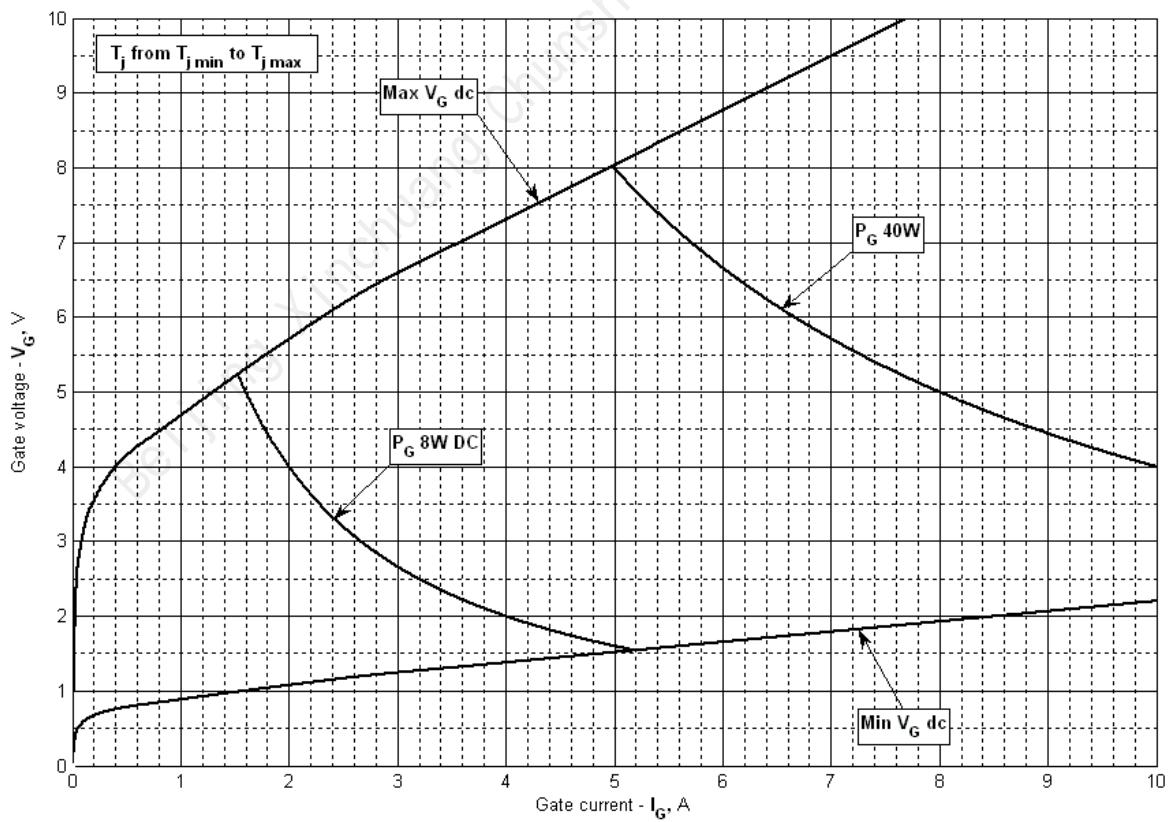


Fig 4 - Gate characteristics –Power curves

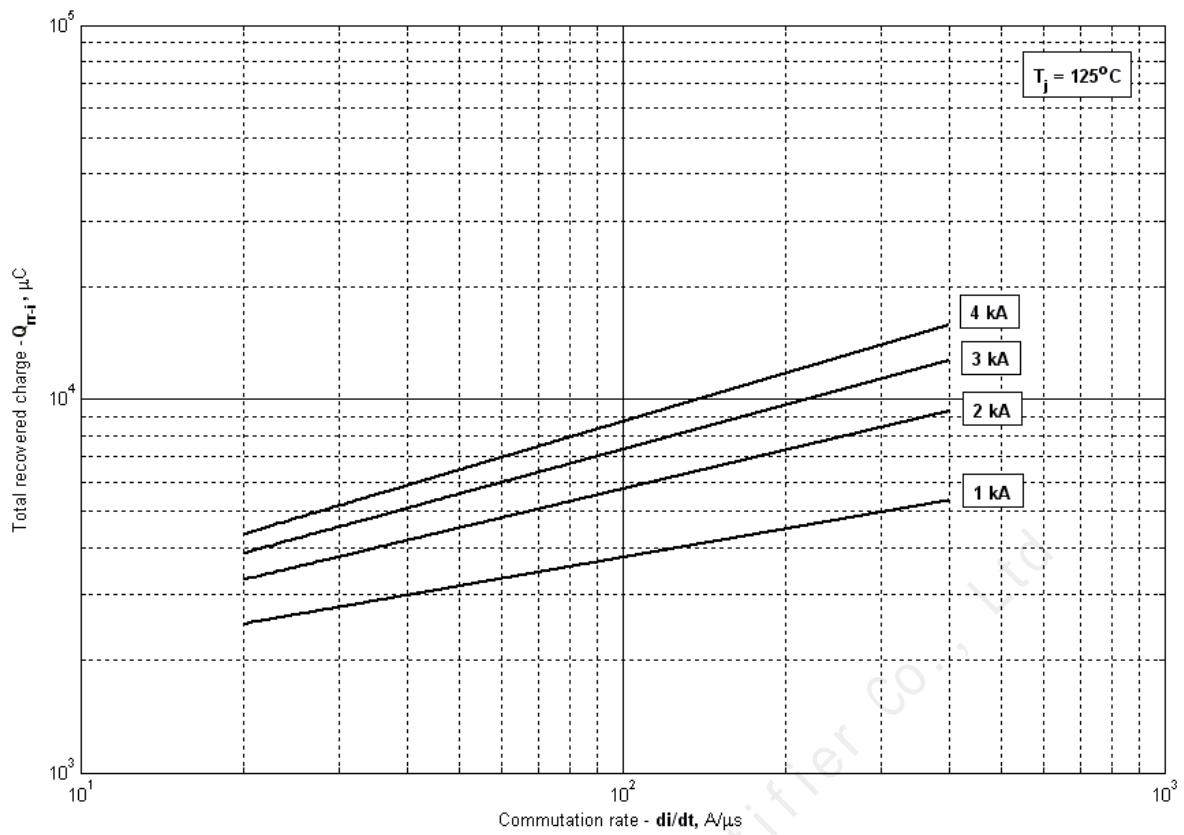


Fig 5 – Total recovered charge,  $Q_{rr-i}$  (integral)

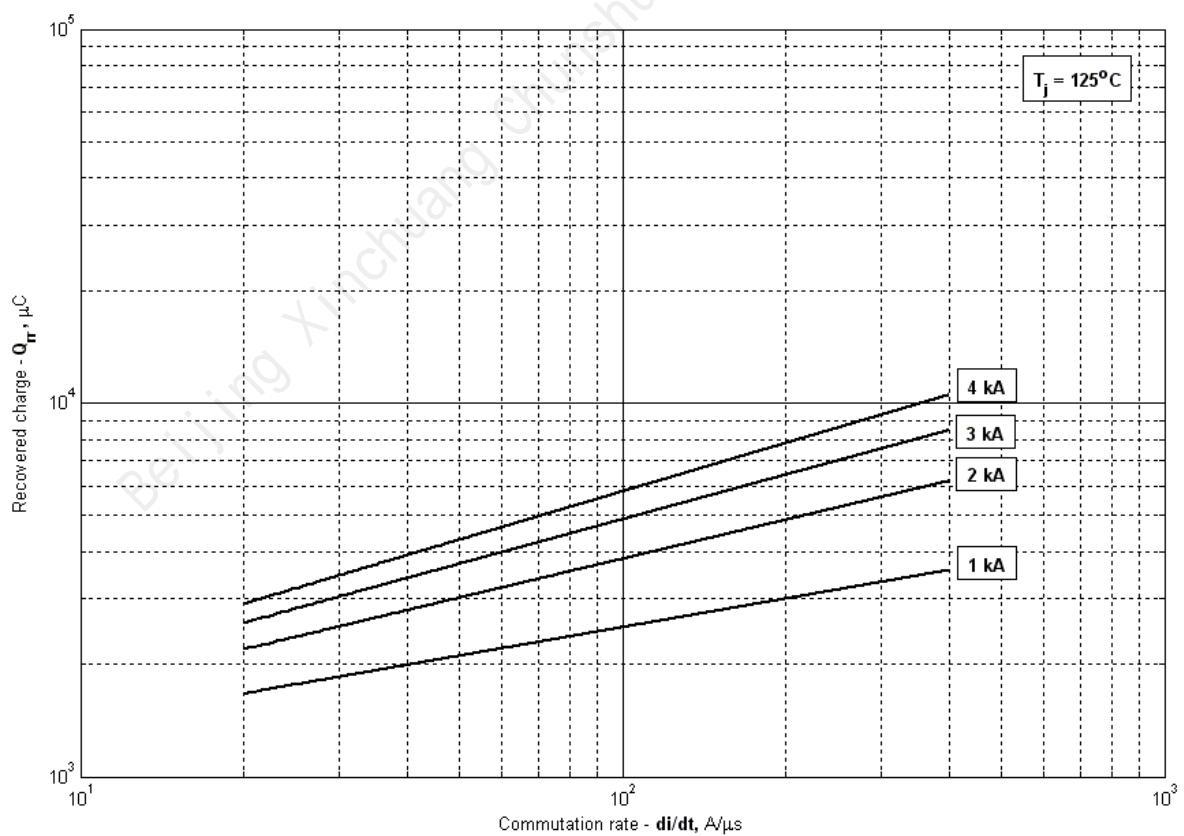


Fig 6 - Recovered charge,  $Q_{rr}$  (linear)

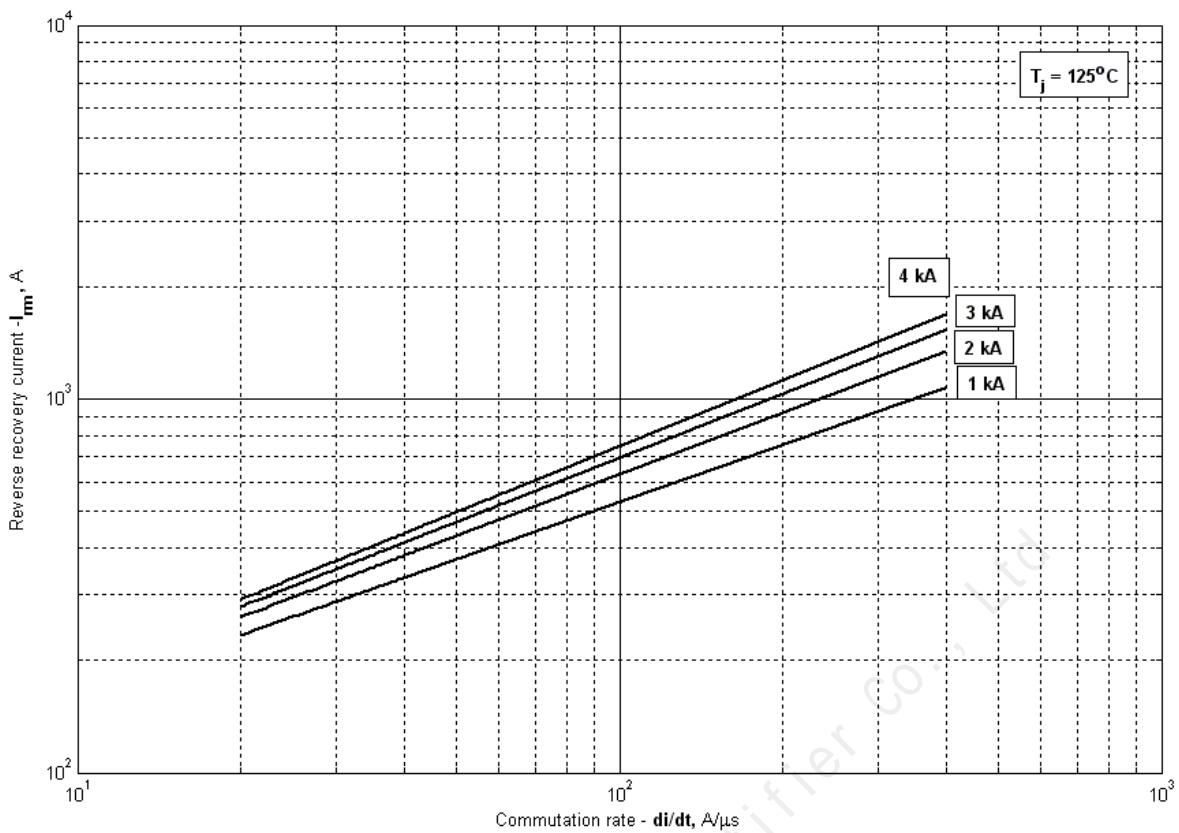


Fig 7 – Peak reverse recovery current,  $I_{rm}$

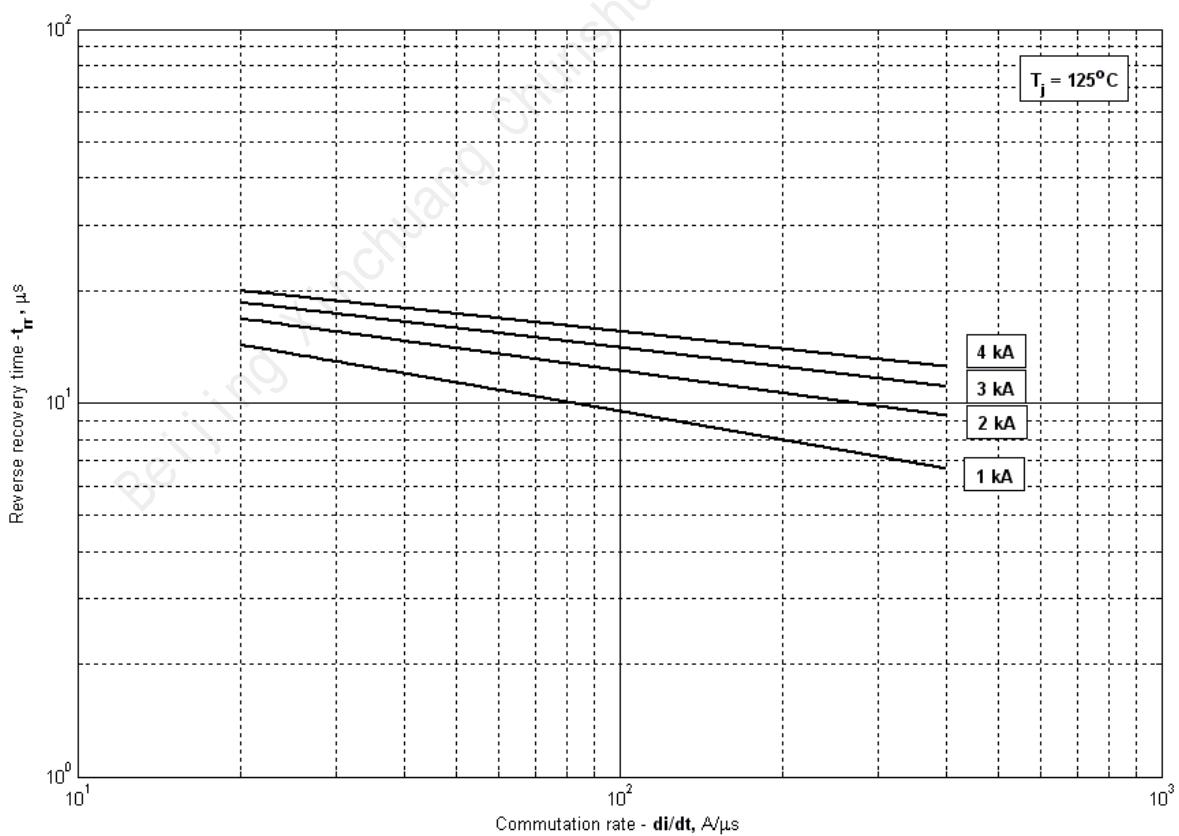


Fig 8 – Maximum recovery time,  $t_{rr}$  (linear)

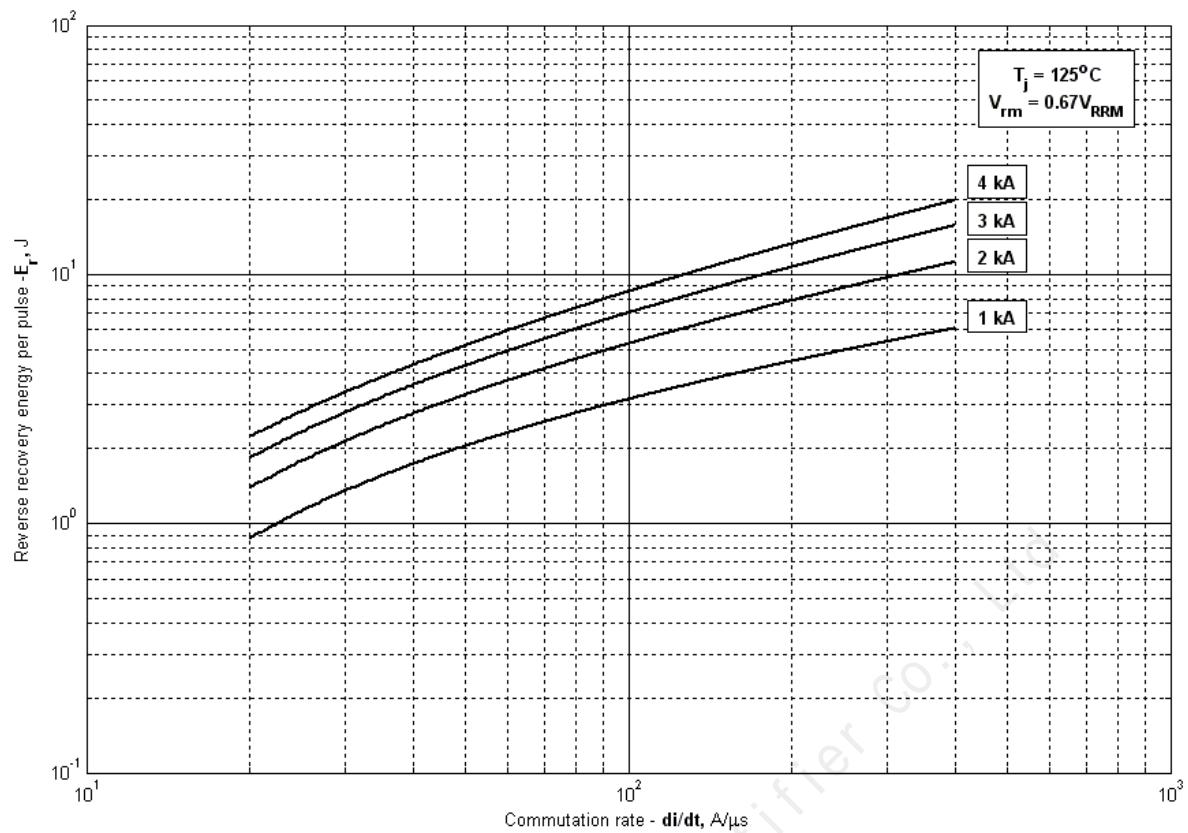


Fig 9 – Reverse recovery energy per pulse

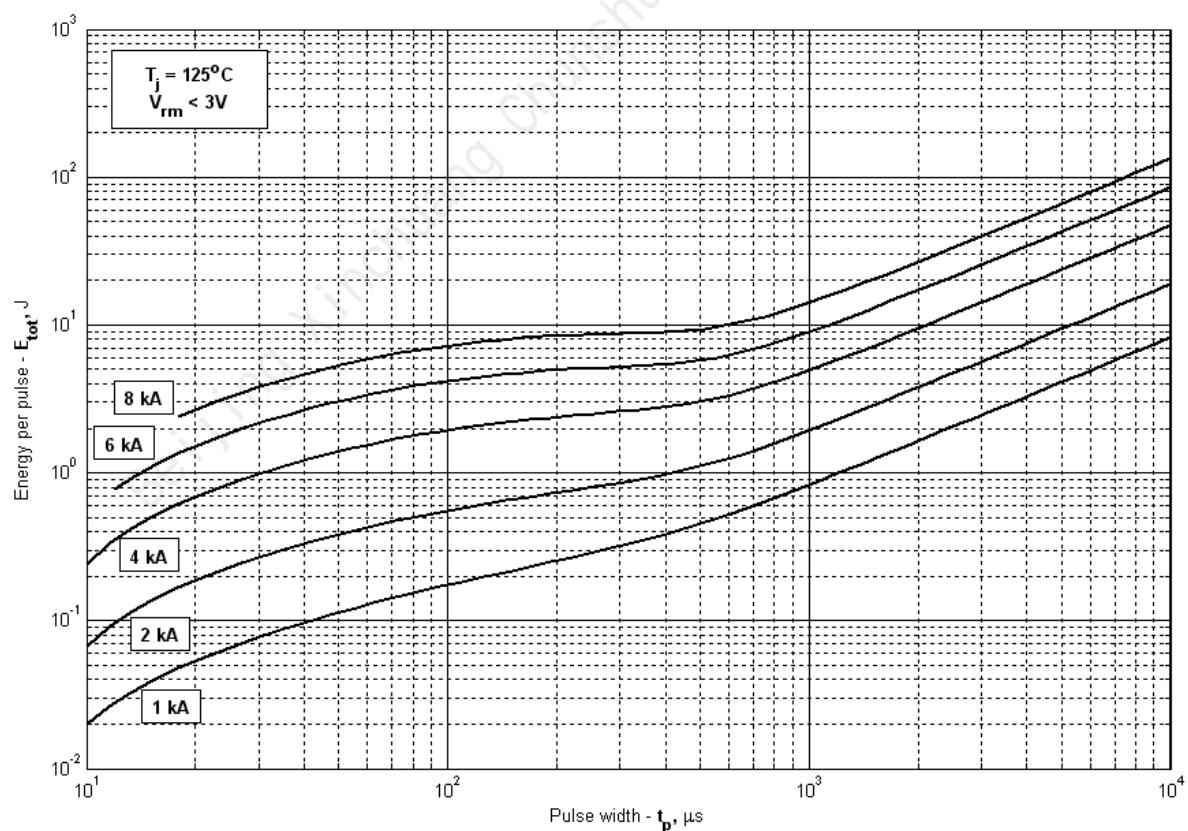


Fig 10 – Sine wave energy per pulse

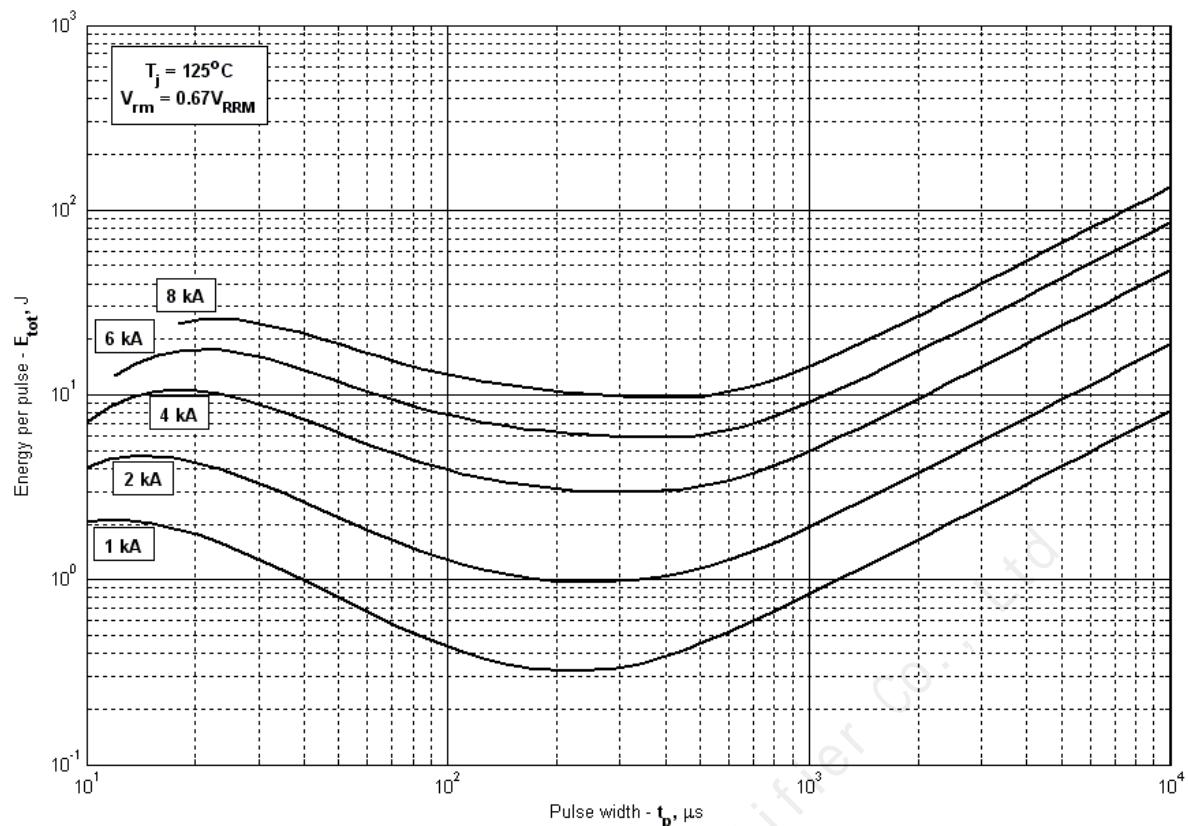


Fig 11 – Sine wave energy per pulse

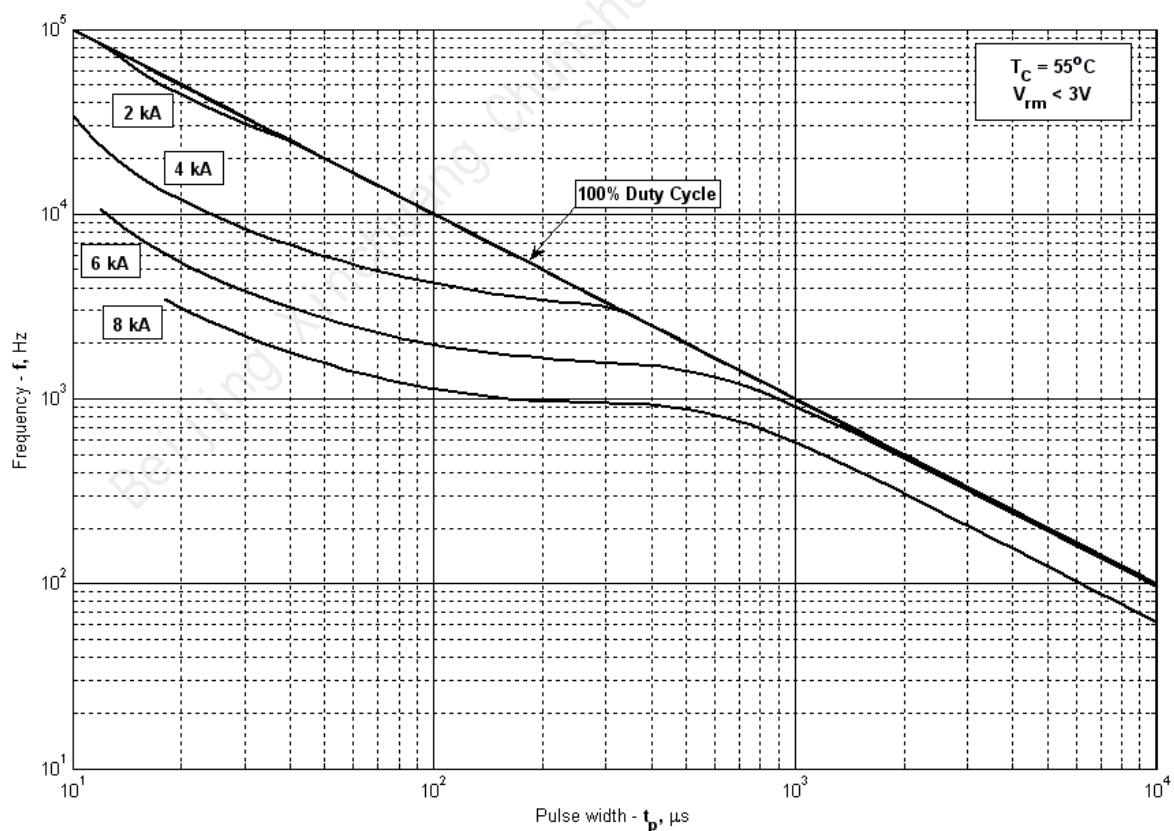


Fig 12 – Sine wave frequency ratings

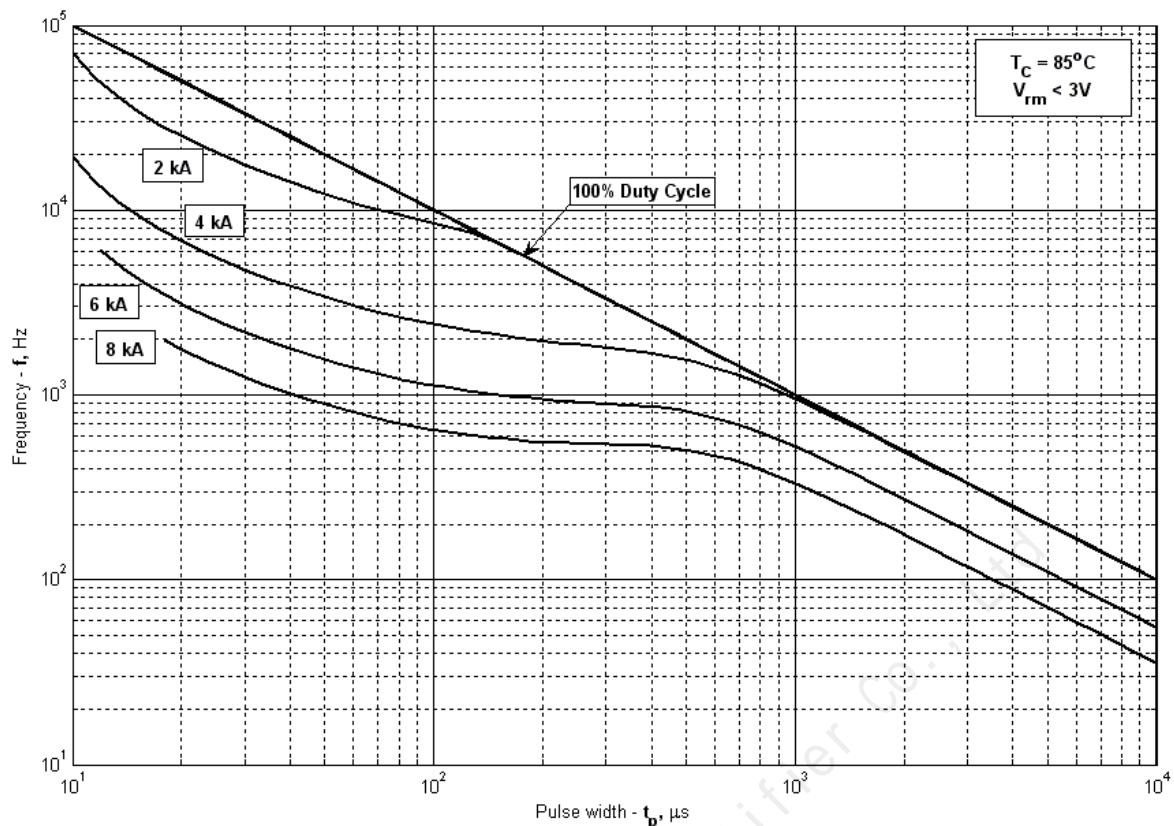


Fig 13 – Sine wave frequency ratings

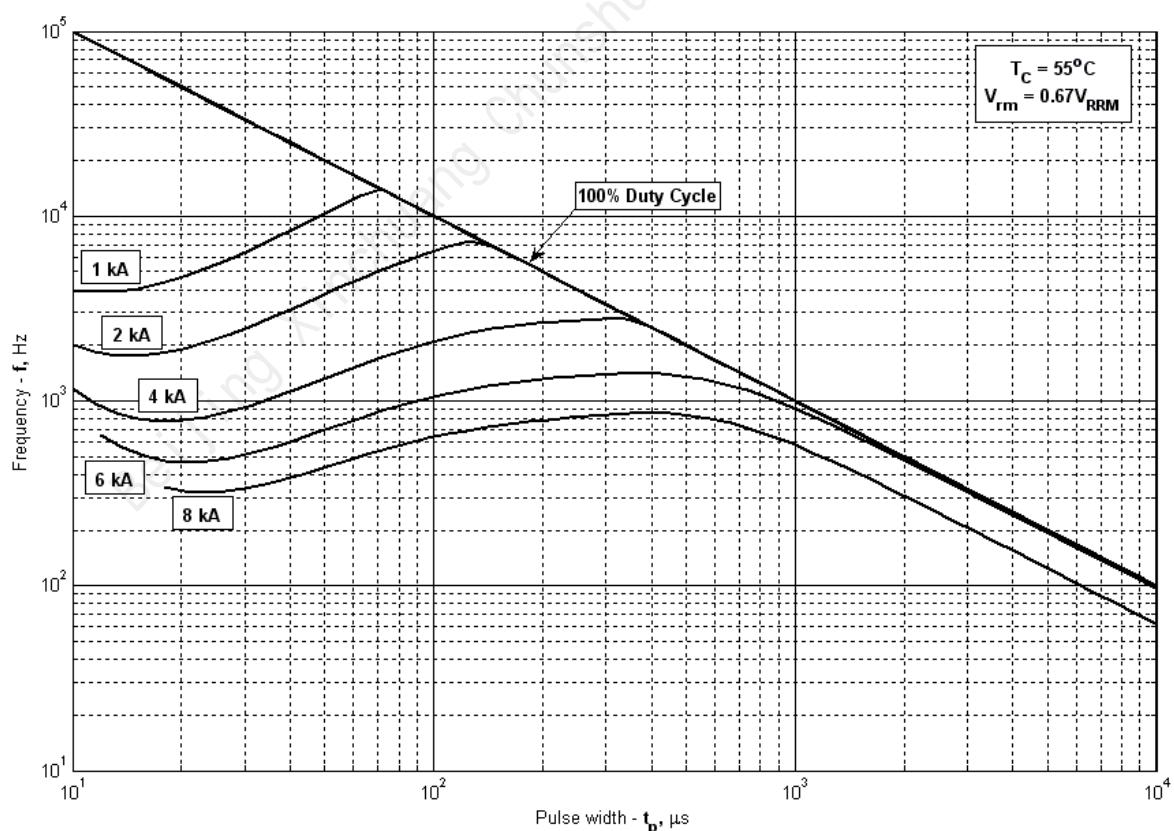


Fig 14 – Sine wave frequency ratings

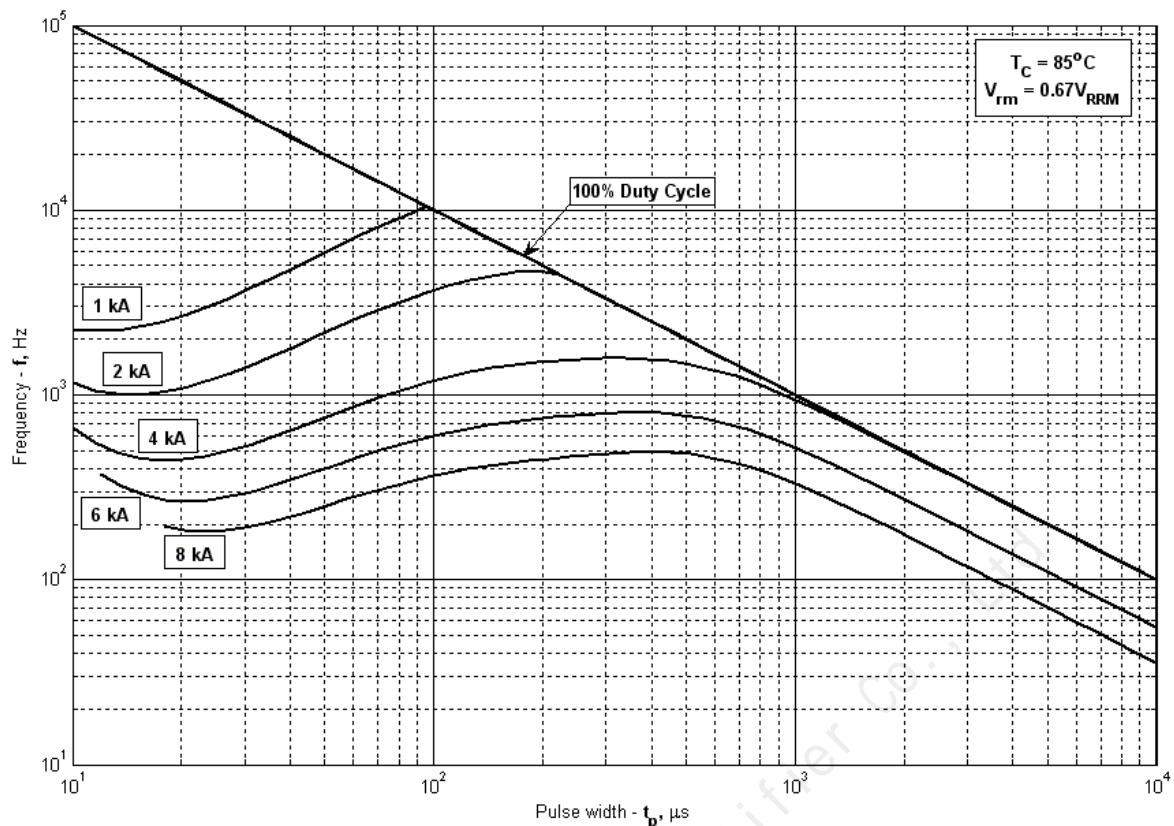


Fig 15 – Sine wave frequency ratings

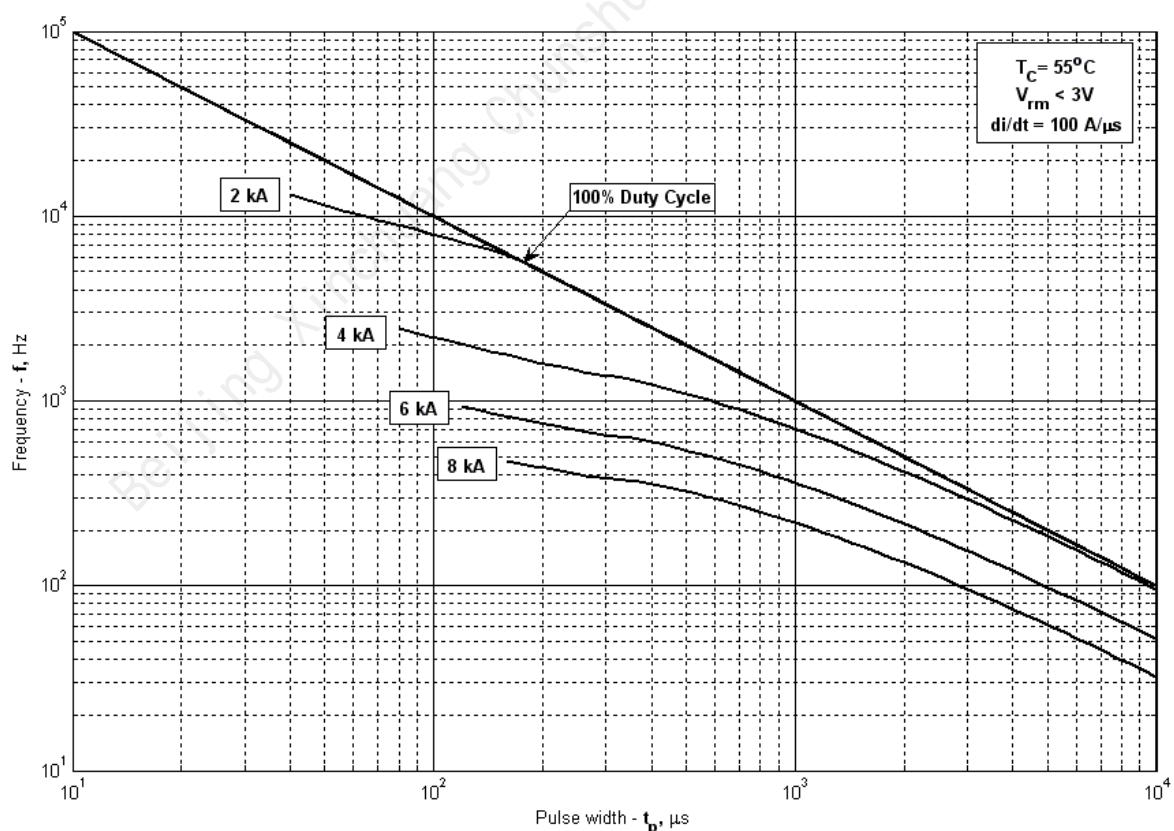


Fig 16 – Square wave frequency ratings

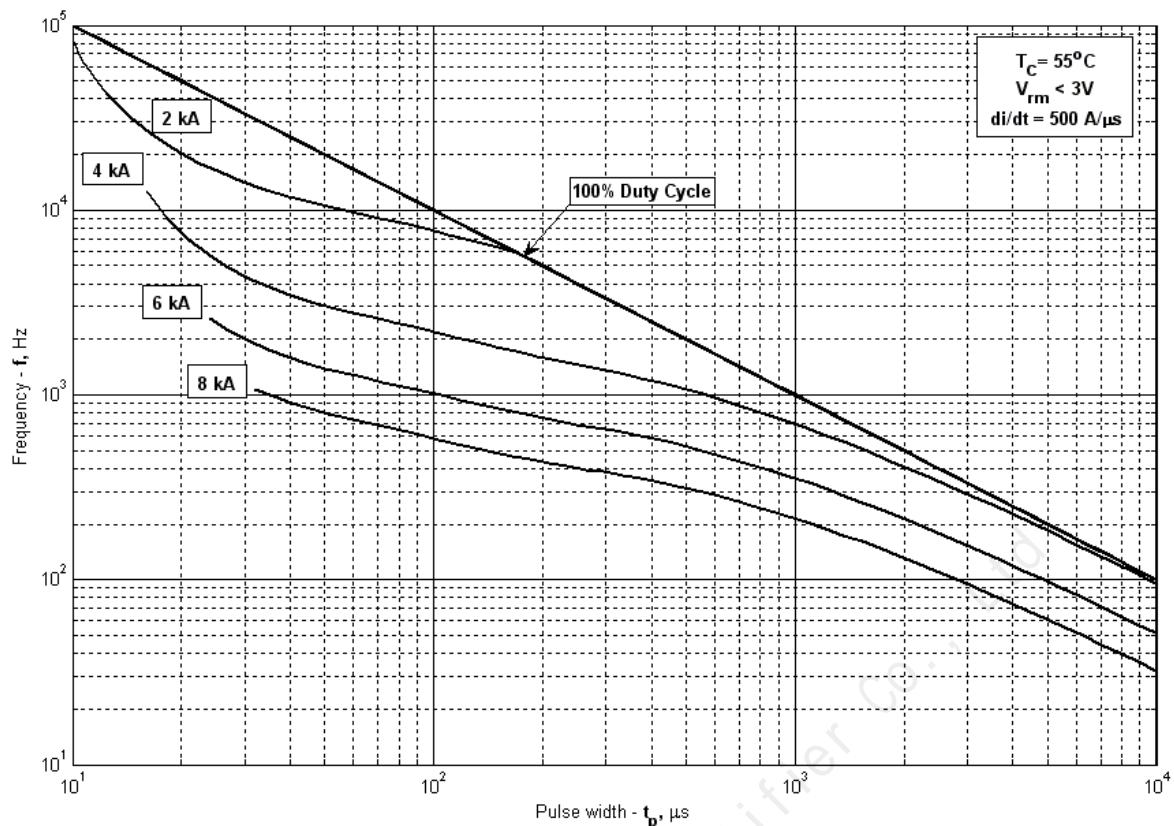


Fig 17 – Square wave frequency ratings

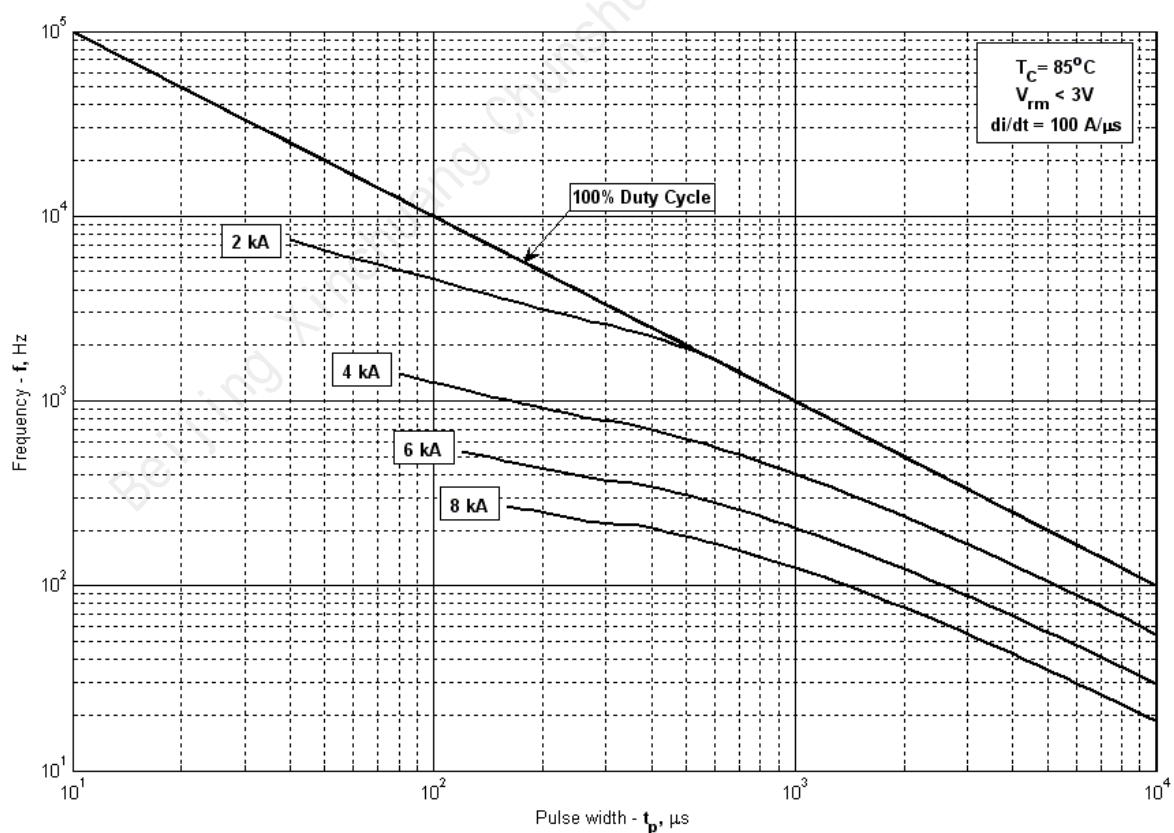


Fig 18 – Square wave frequency ratings

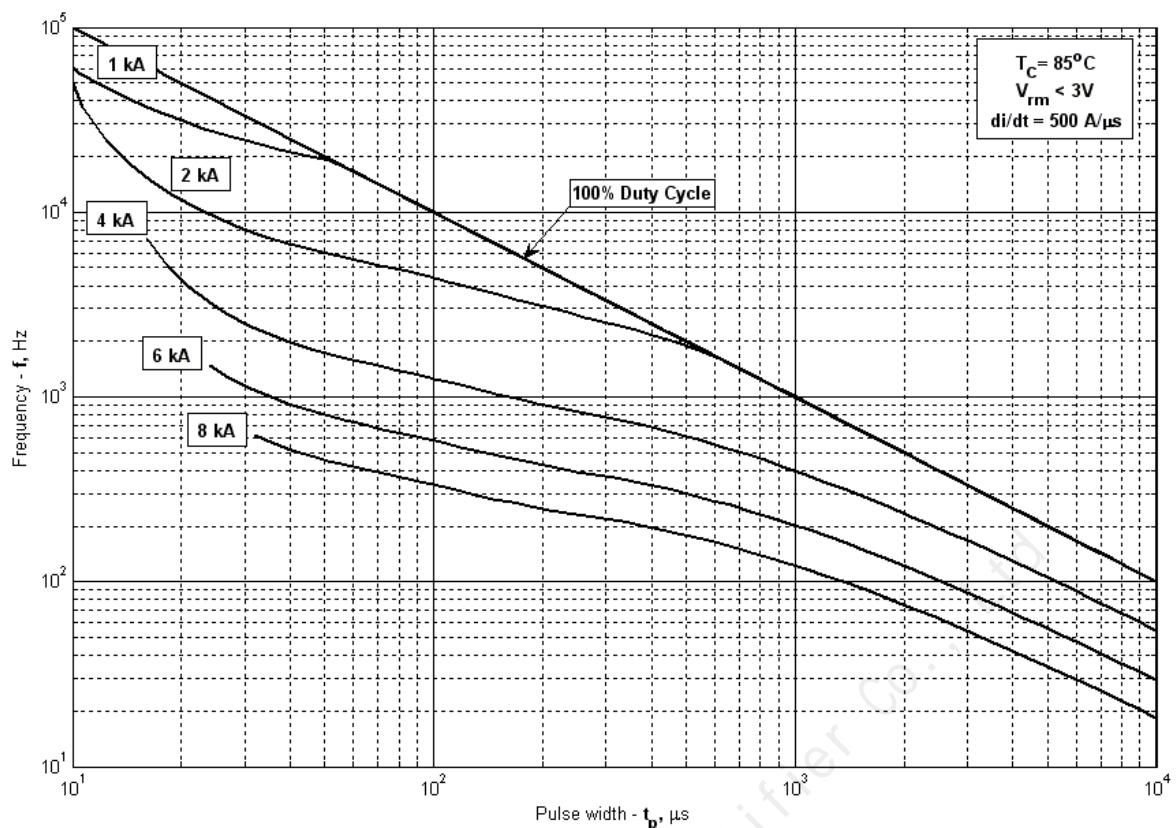


Fig 19 – Square wave frequency ratings

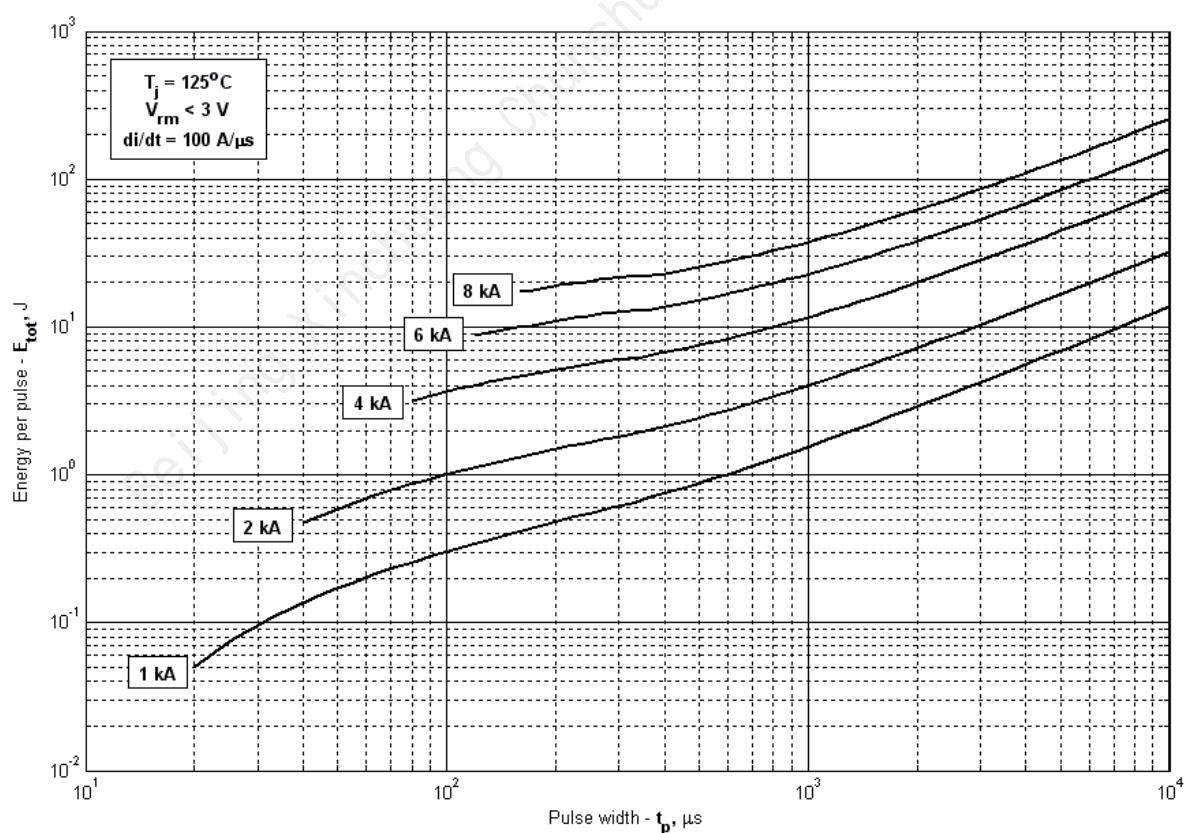


Fig 20 – Square wave energy per pulse

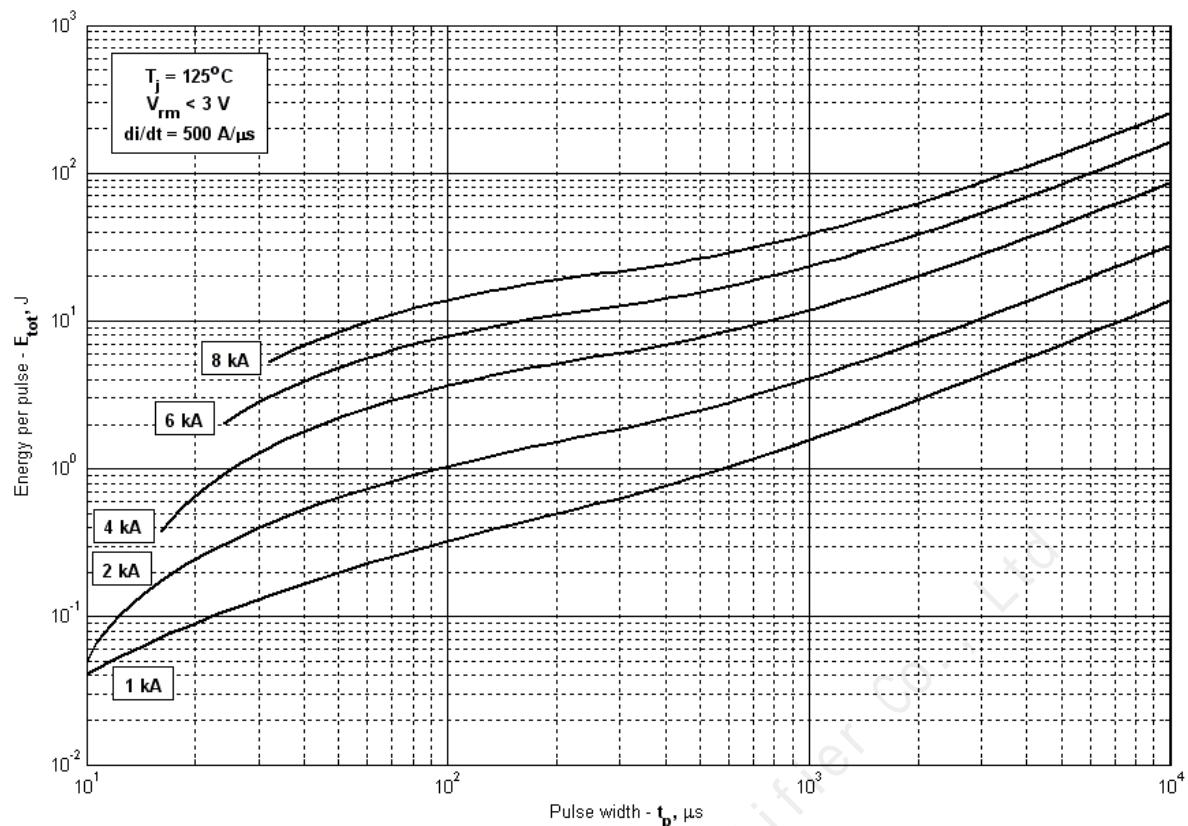


Fig 21 – Square wave energy per pulse

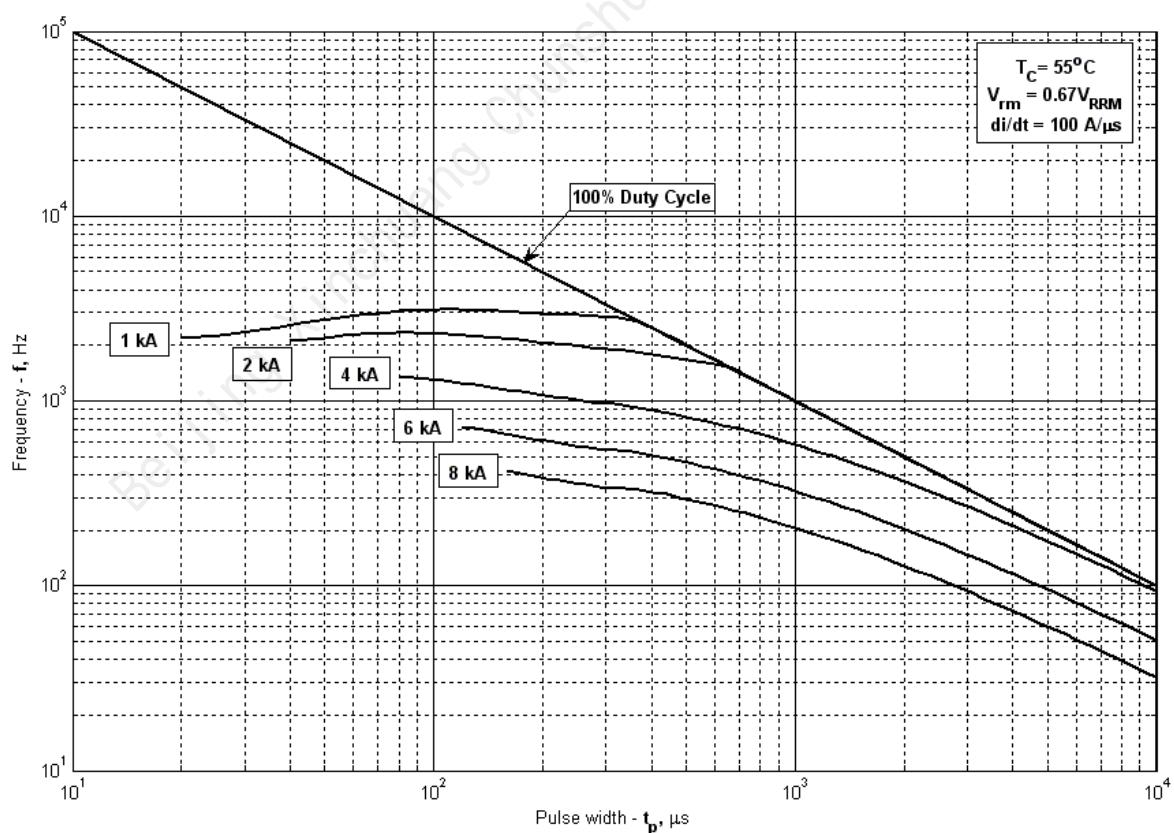


Fig 22 – Square wave frequency ratings

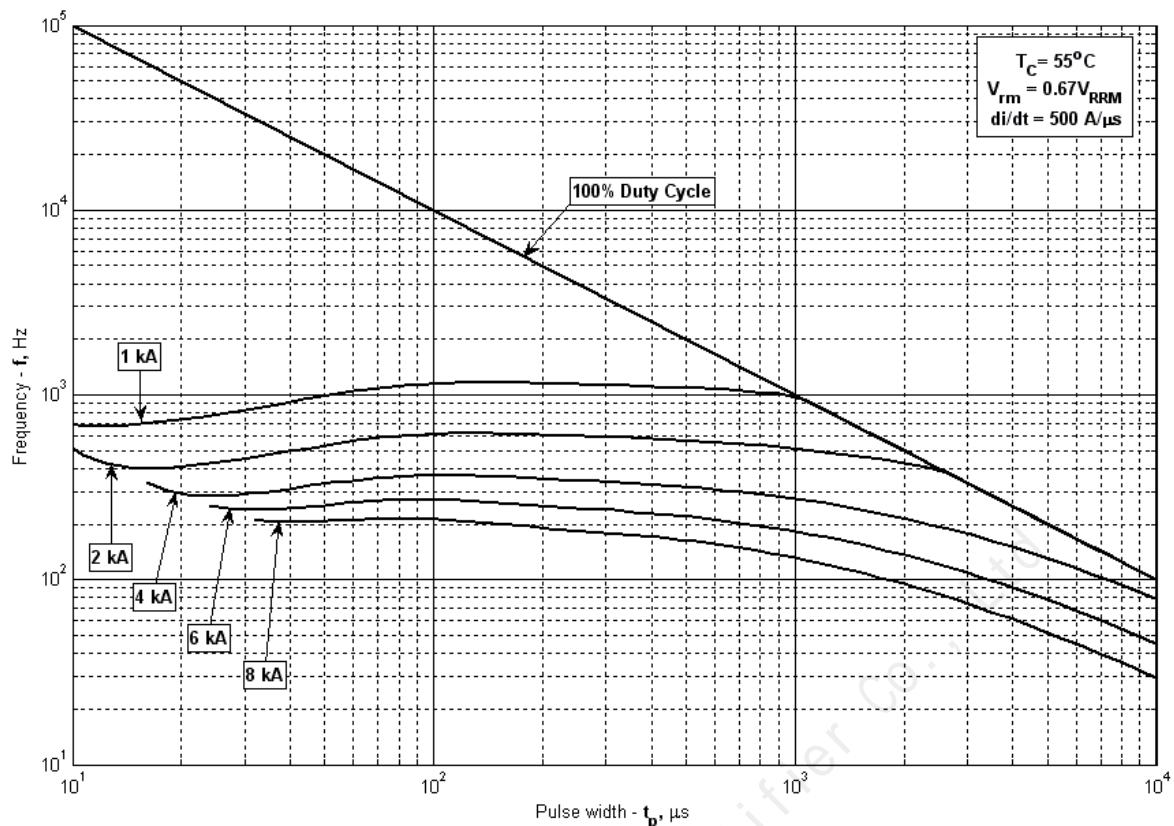


Fig 23 – Square wave frequency ratings

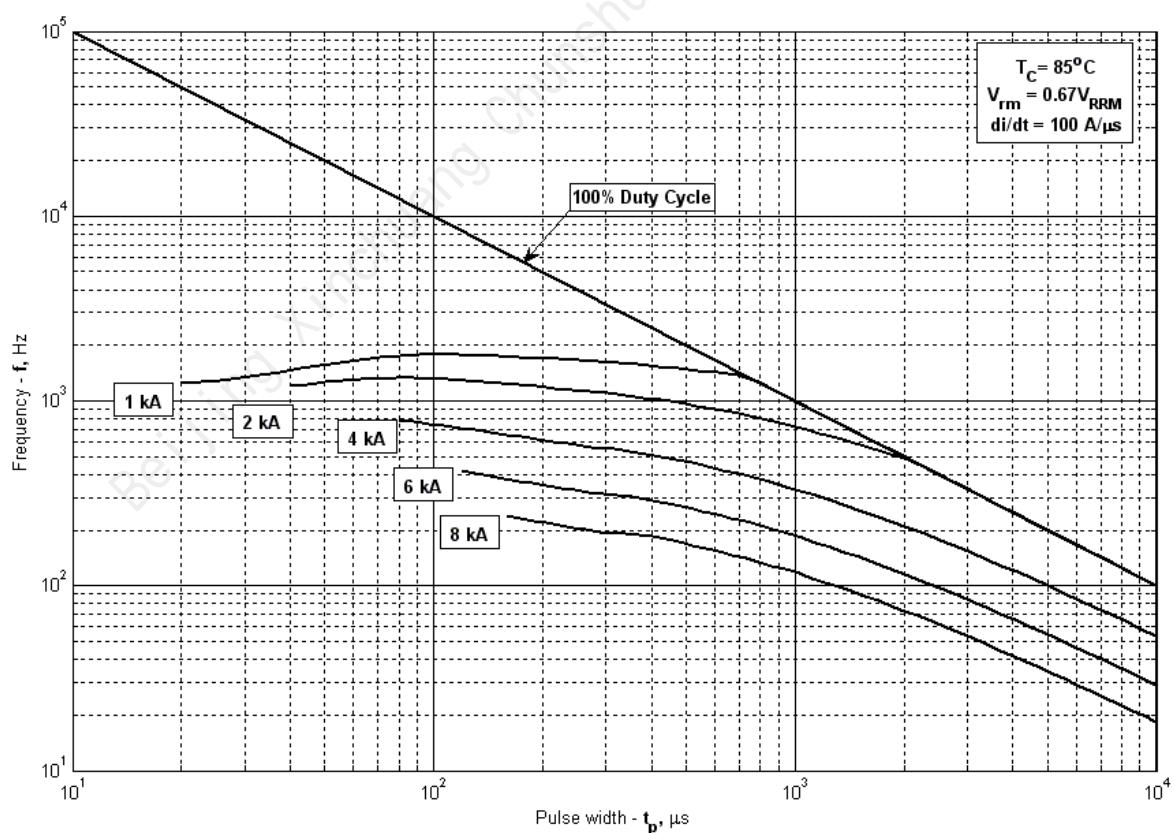


Fig 24 – Square wave frequency ratings

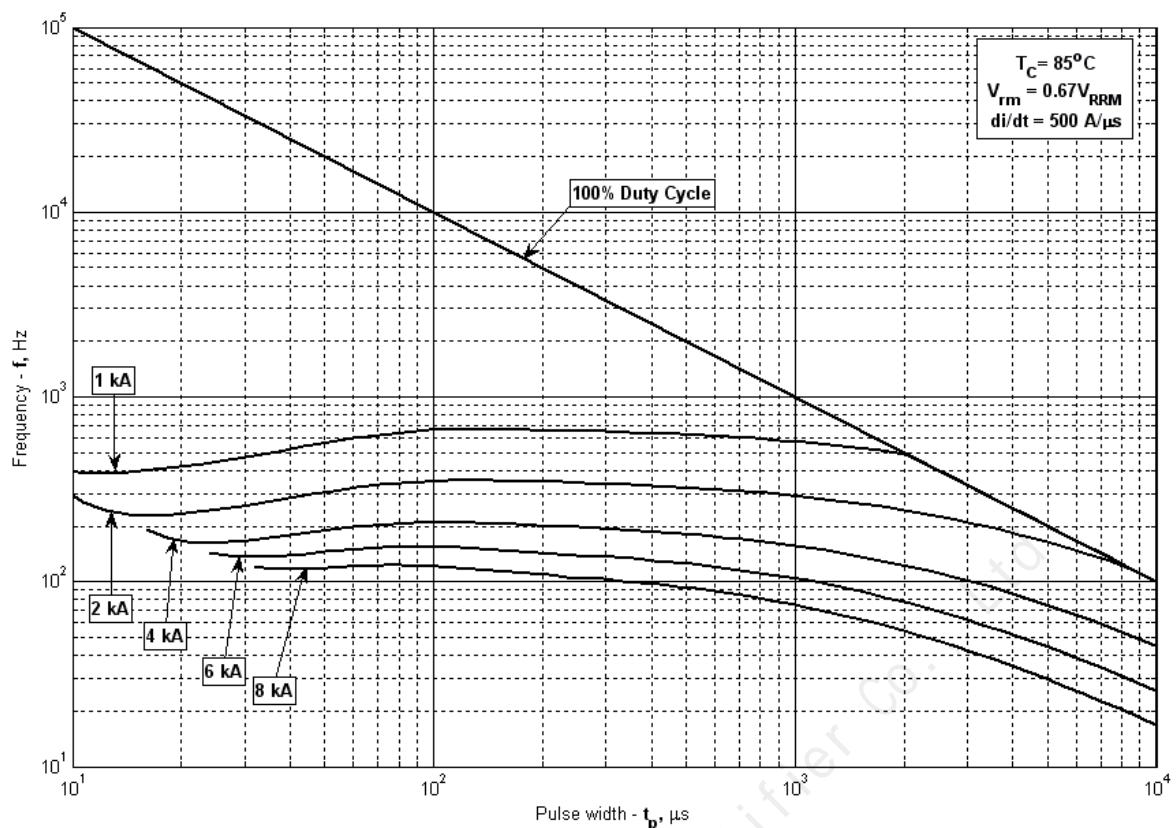


Fig 25 – Square wave frequency ratings

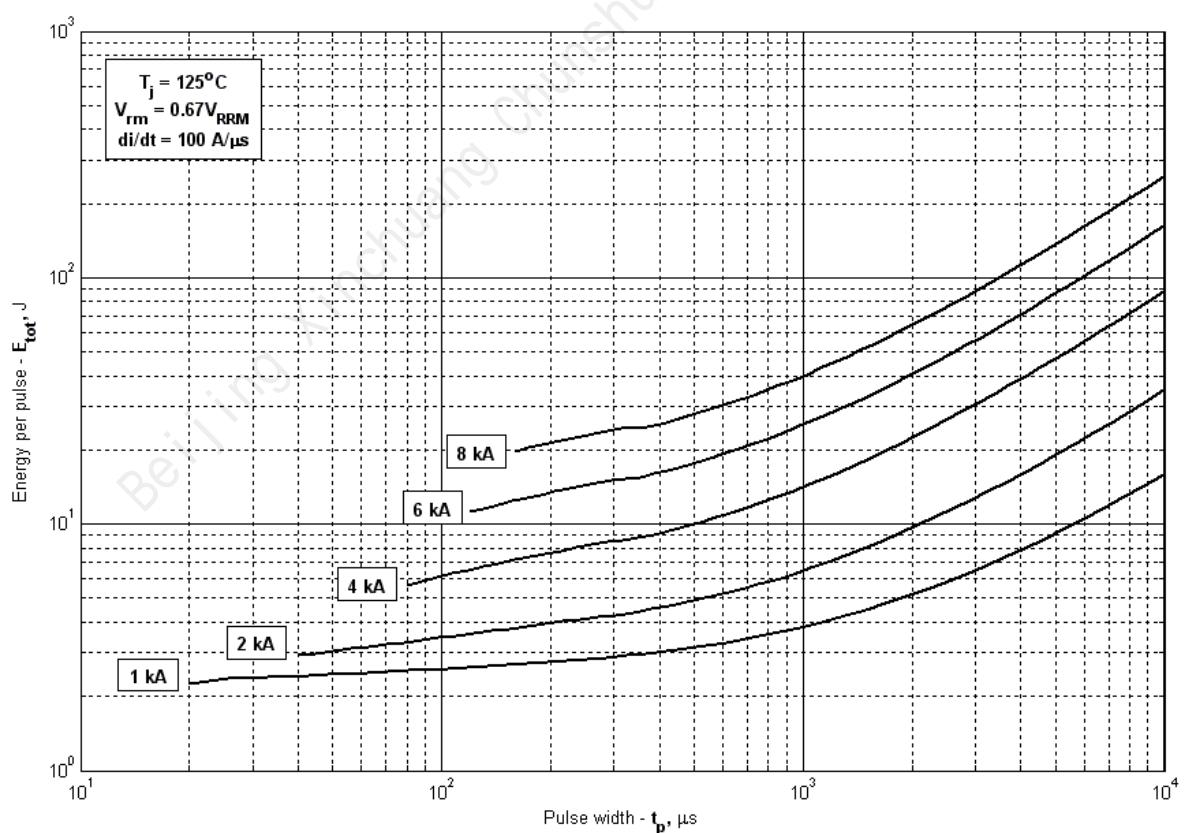


Fig 26 – Square wave energy per pulse

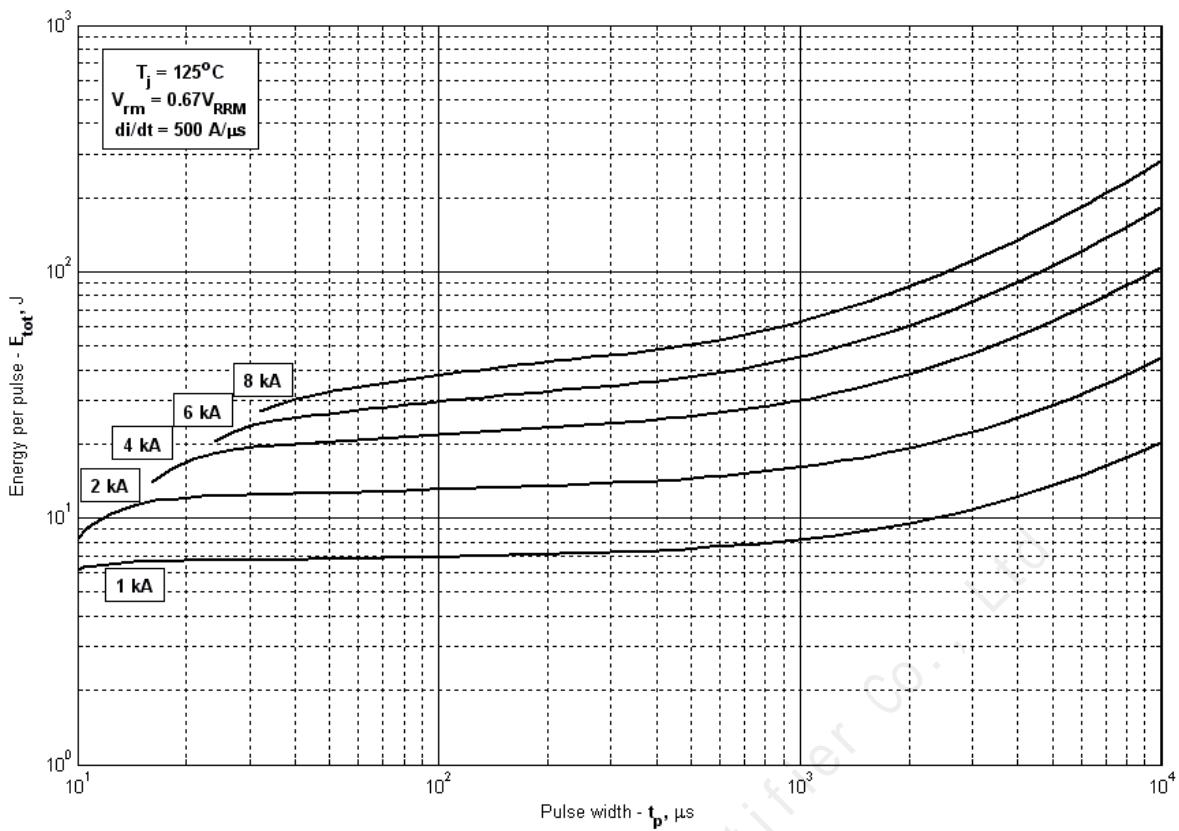


Fig 27 – Square wave energy per pulse

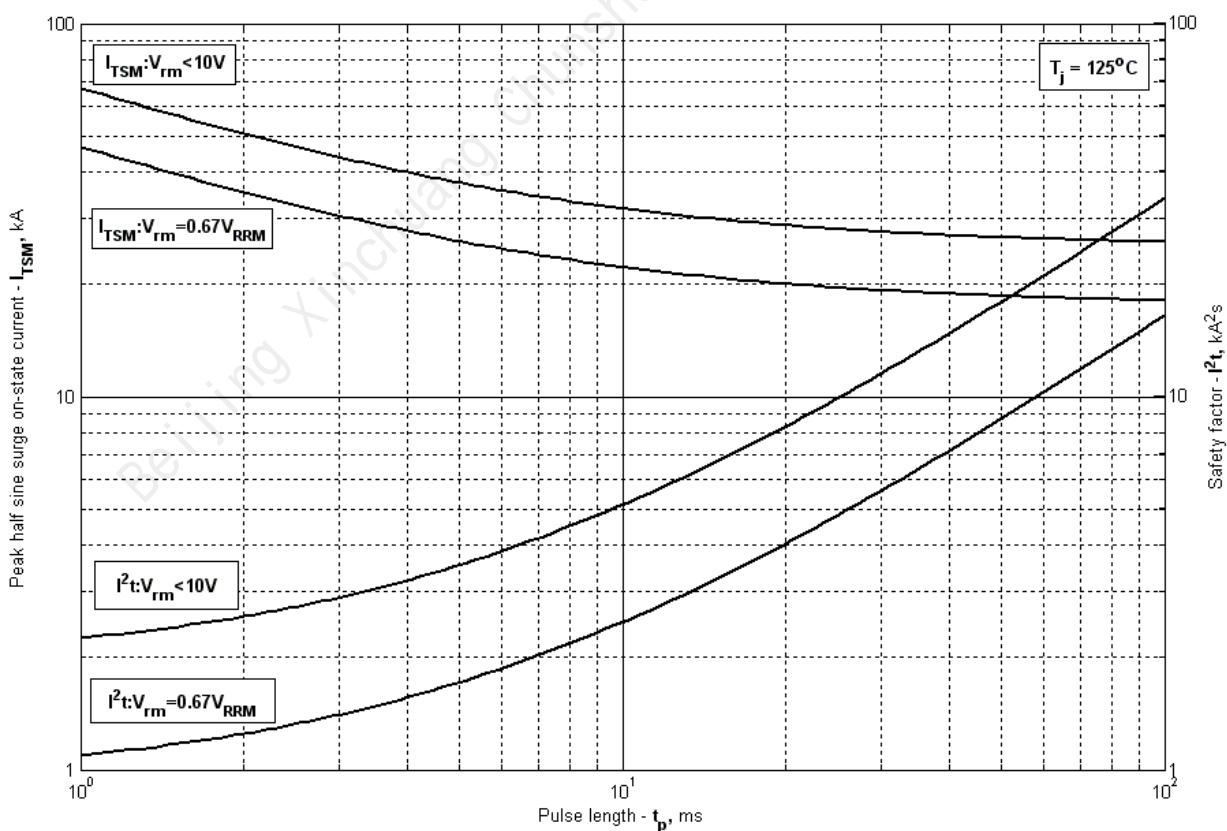


Fig 29 – Maximum surge and  $I^2t$  ratings

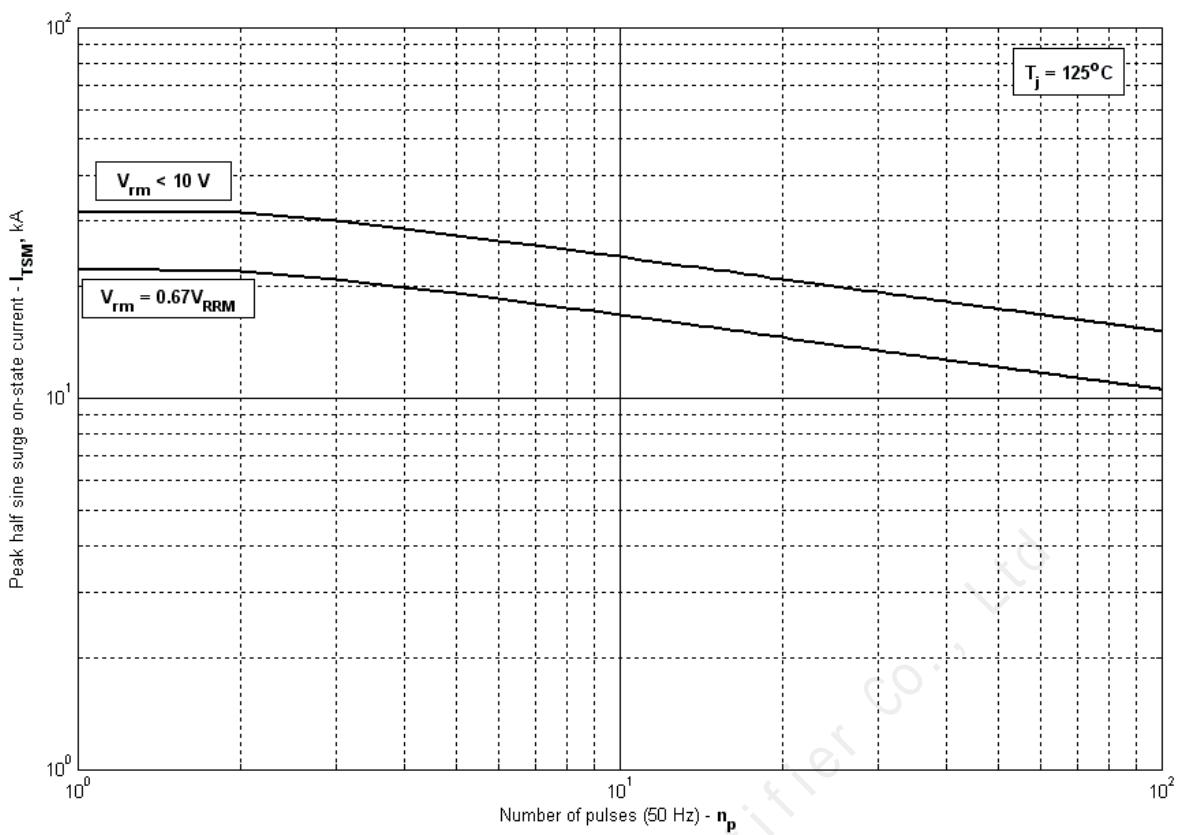


Fig 30 – Maximum surge ratings